

Statistical and systematic uncertainties in a and A

J. David Bowman

SNS FPNB Magnet Meeting

North Carolina State University

Jan. 8, 2006

Statistical errors in a and A

$$\sigma_a = \frac{2.33}{\sqrt{N}} \text{ from proton TOF}$$

$$s_a = \frac{15.3}{\sqrt{N}} \text{ from e - p correlations without TOF}$$

$$\frac{dN}{dt} \sim 30 \text{ Hz/cc}$$

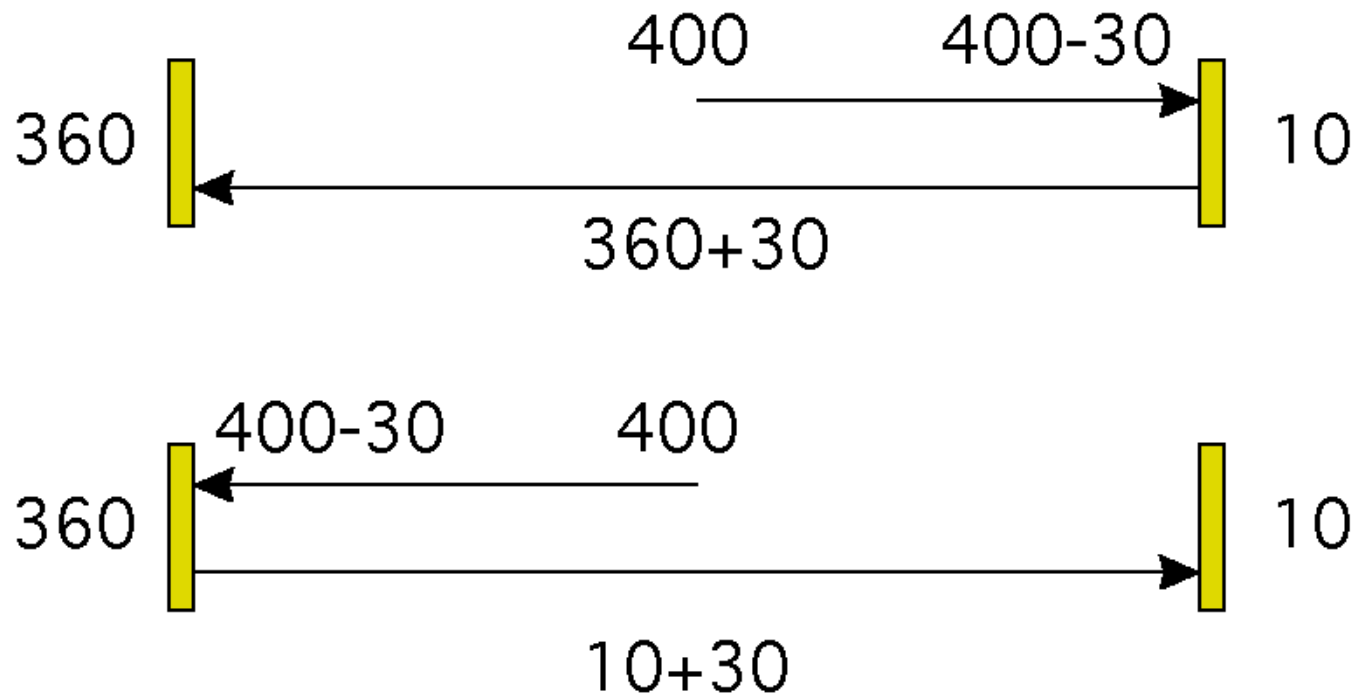
$$s_A = \frac{2.69}{\langle Pol \rangle \sqrt{N}} \text{ (from spin - electron correlation)}$$

$$\frac{dN}{dt} \sim 4 \text{ Hz/cc,}$$

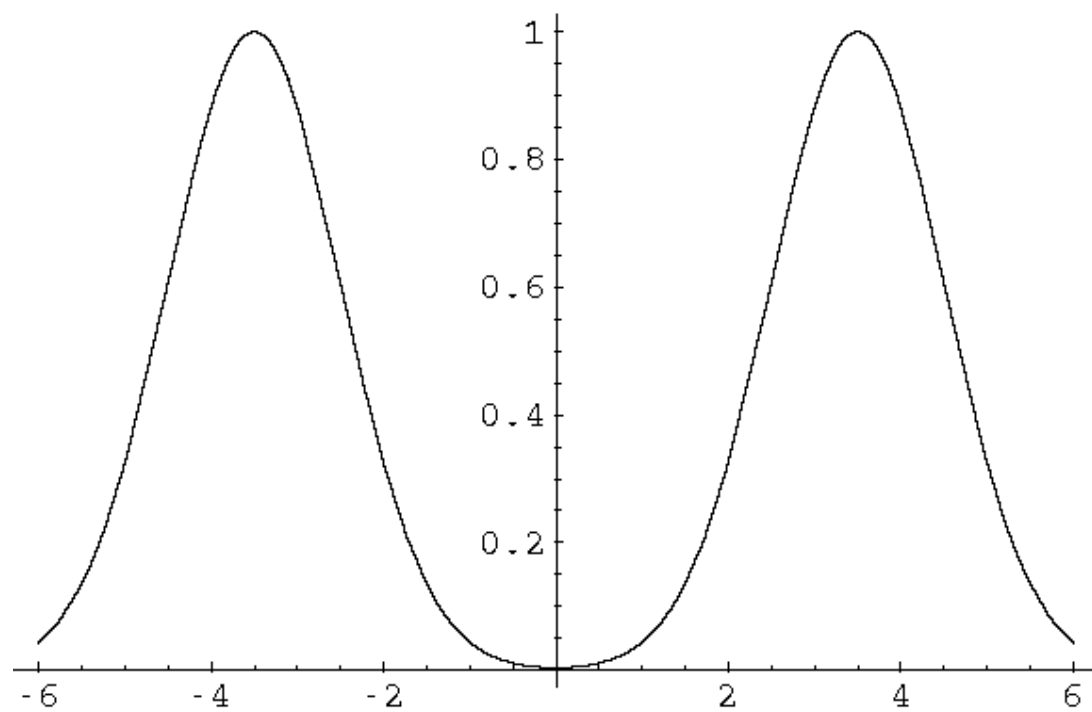
(\sim 4 loss from polarizer and 2 loss from frame selection)

Electron scattering from Si detectors

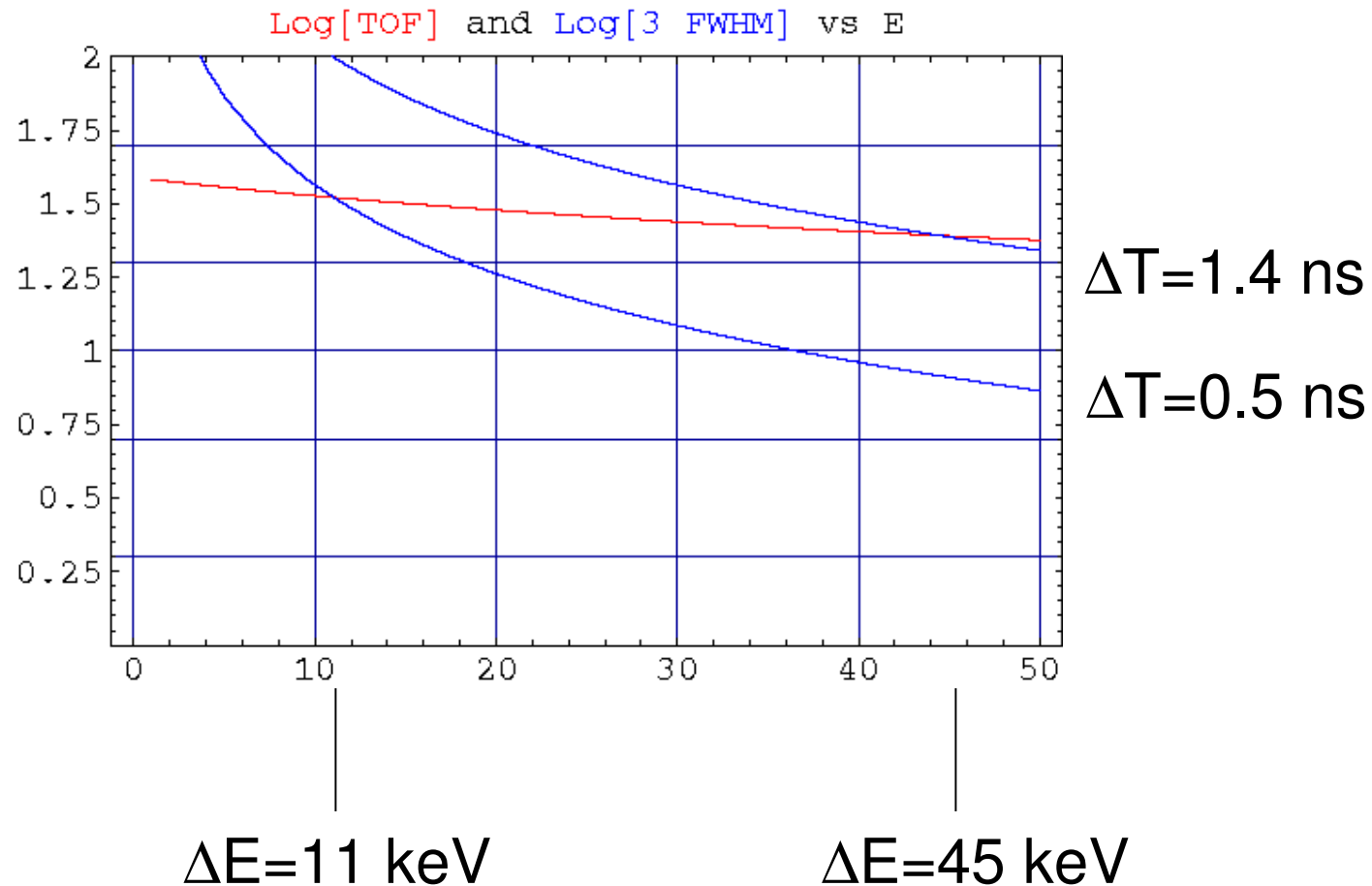
Electron energies in keV



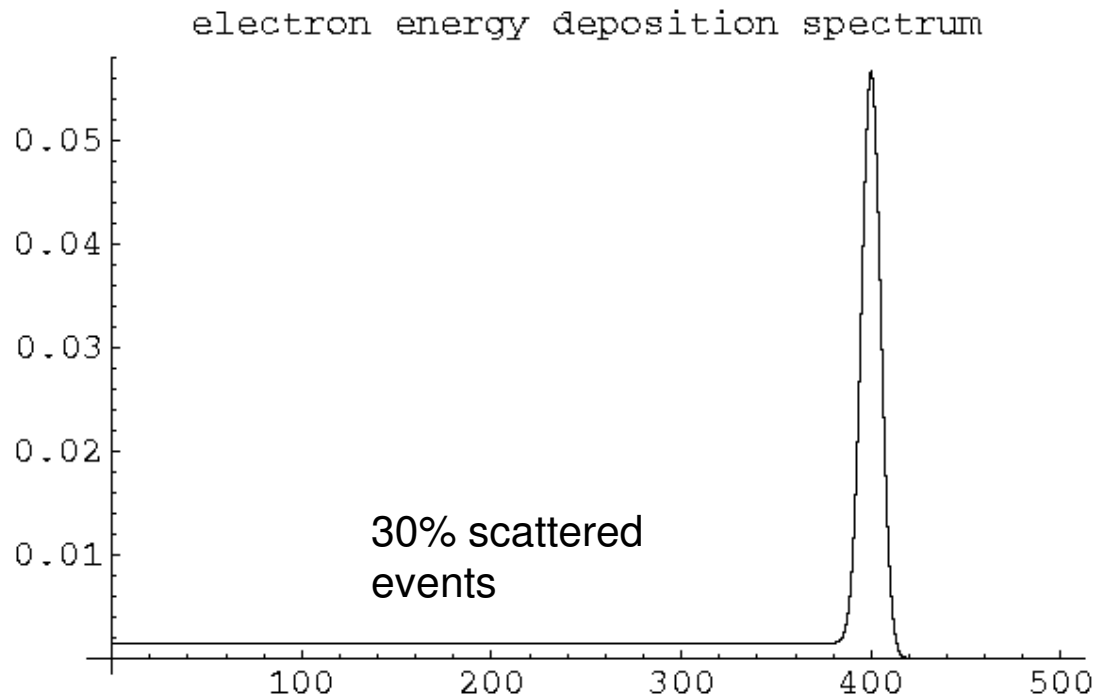
two gaussians seperated by 3 FWHM



ΔTOF and 3 FWHM vs ΔE



430 keV electron



Estimate correction to A

$$A_{measured} = A_{?} - f \frac{DE}{E}$$

DE = Energy threshold, assume 11 keV.

Assume an electron energy $E = 400$ keV.

$f \sim .3$ for normal incidents, but larger for oblique incidence.

f is correlated with $\text{Cos}[J]$.

$$\text{For } f = .5, DE = 11, f \frac{DE}{E} = 1.5\%.$$

The correction is large compared to .1% and must be accurately modeled and measured. We need to determine the correction to 2%!

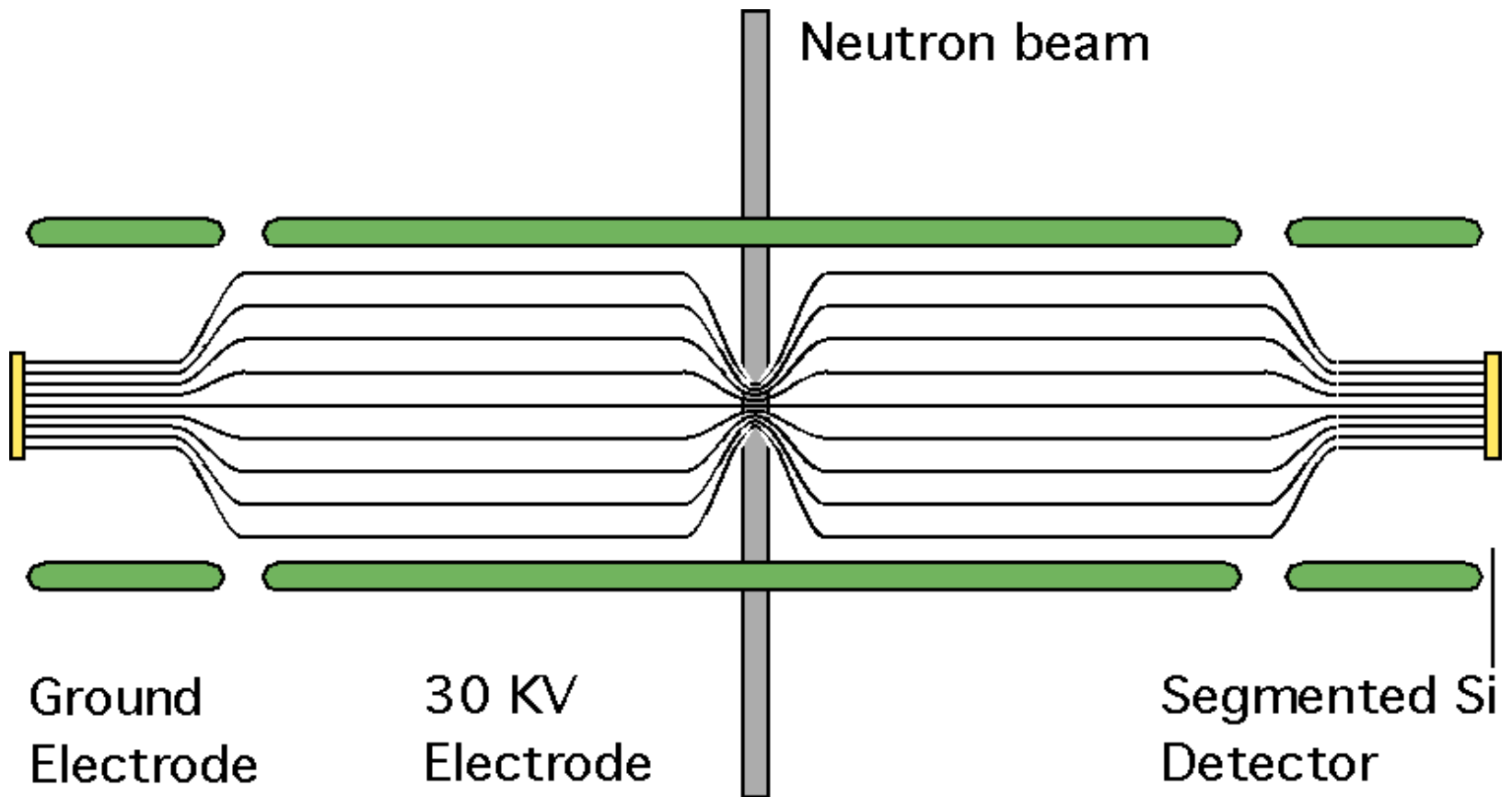
The spectrometer must be optimized to reduce the correction.

1. Increase the field expansion (but reduces the rate)
2. Decrease the accelerating potential
3. Reduce the detector noise
4. Reduce the detector time resolution
5. Increase the spectrometer length

The correction to a is smaller,
because the proton does not back
scatter and the electron TOF $\sim 10^{-3}$
proton TOF

The systematic uncertainty in a must
be evaluated. The most important
systematic uncertainty in a is from
the field map in the decay and
expansion regions

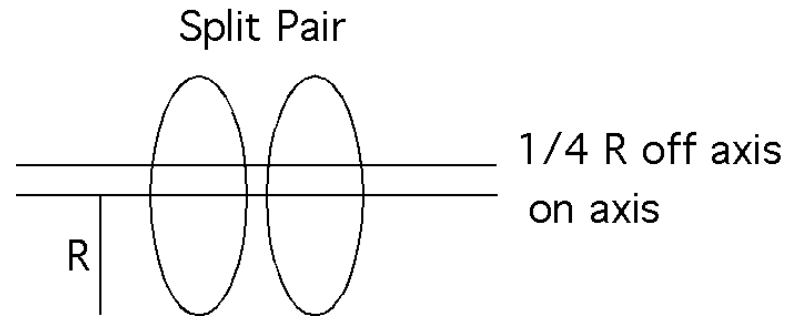
A/a spectrometer



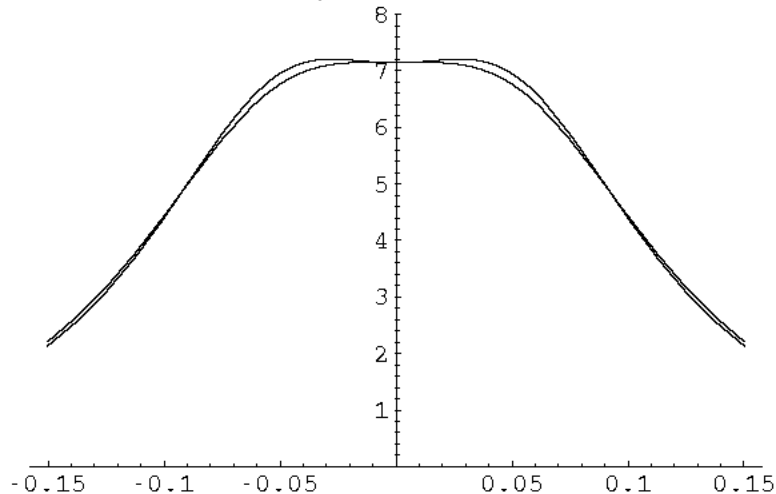
The a and A spectrometers are compatible

- $\sim \times 4$ field expansion
- The large field expansion required by a (~ 20) makes the proton TOF spread smaller for A and reduces the width of the time distribution.
- The A experiment is more sensitive to reflection in the decay region and requires a higher field homogeneity than the a experiment.
- The a experiment requires a rapid field expansion to achieve a good separation between $\text{TOF} = dL/Pz$ in the decay region and $\text{TOF} = DL/P$ in the drift region

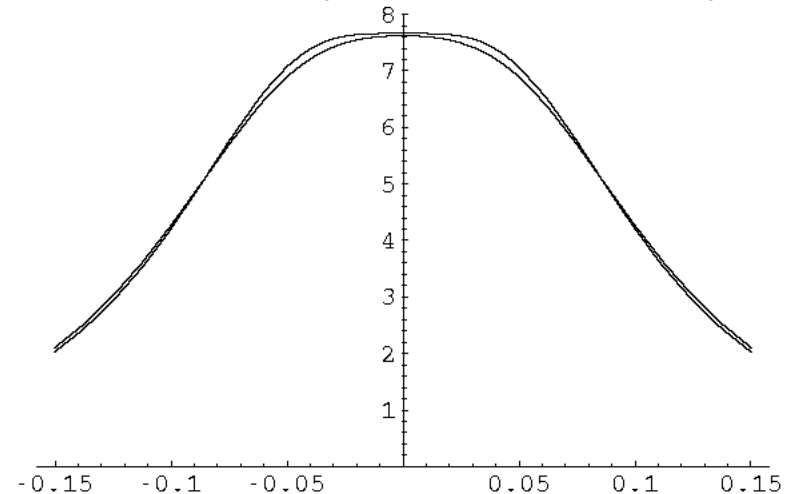
Split pair can produce an electron trap



Bz on axis and R/4 for HH condition at $r=0$



Bz on axis and $r/4$ for HH condition at $R/4$



electron/proton reflections

$$B = B_0 \left(1 - g \frac{z^2}{z_0^2} \right)$$

Assume $g = .01$

$$\text{Reflection probability} = \frac{\sqrt{g}}{2} = .05$$

$$A_{\text{measured}} = A_0 \left(1 - \frac{g}{3} \right) \approx 3 \times 10^{-3} \text{ correction}$$

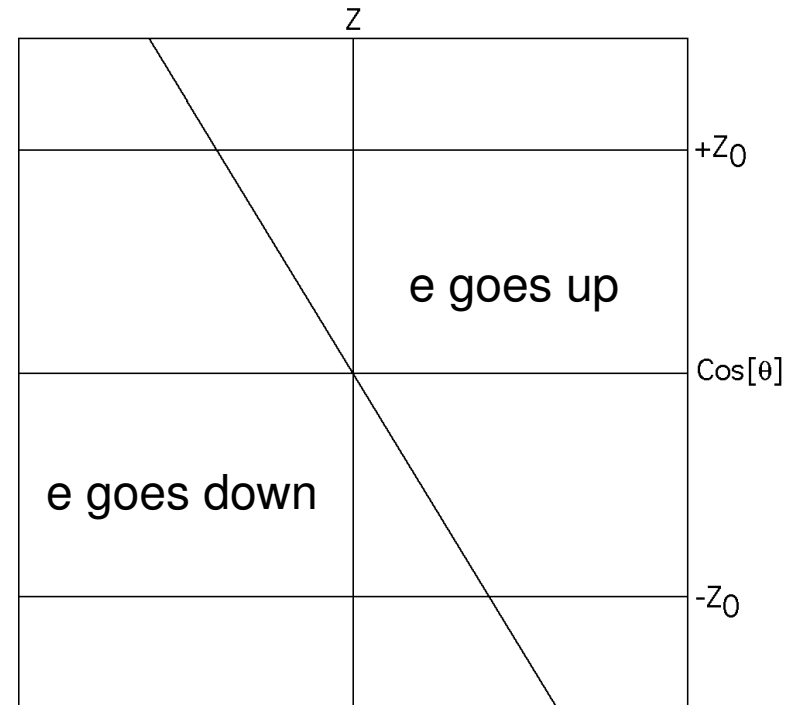
$$\text{If the field is not symmetric, } B = B_0 \left(1 - g \frac{z^2}{z_0^2} + d \frac{z^3}{z_0^3} \right)$$

$$A_{\text{measured}} = A_0 \left(1 - \frac{g}{3} - \frac{d}{6\sqrt{g}} \right)$$

For $g = .01$ and $d = .001$,

the second term is 1.6×10^{-3}

We must map the field!



$$\text{Cos}[J] = \sqrt{g} \frac{z}{z_0}$$

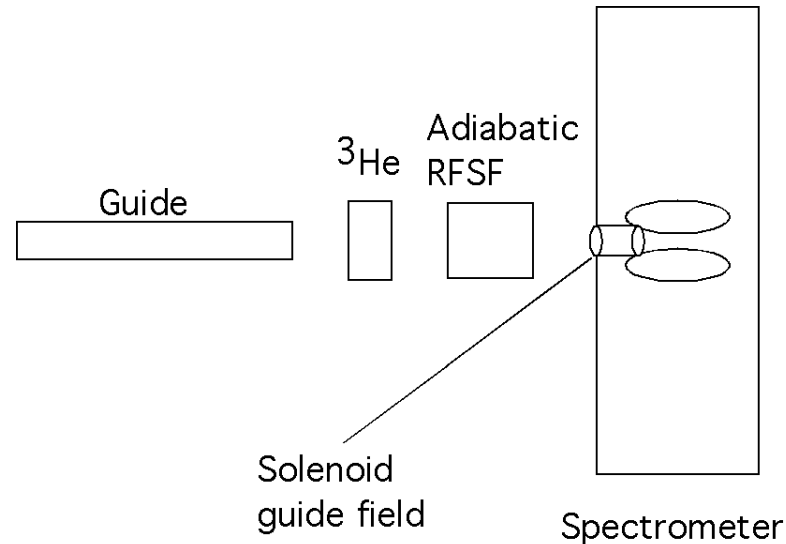
Precision polarimetry

(discussed in Pentilla and Bowman, NIST workshop)

- For a ^3He polarizer, $B(t) = B \tanh(-t/\tau)$.
Determine both B and τ from a fit to TOF spectrum
- Neutron pulse width, ^3He cell thickness variations, drifts, depolarization by magnetic impurities in cell walls, ... all $< 10^{-4}$.
- Largest uncertainty is from β -delayed neutrons in spallation source. Measure in SNS commissioning run.

Neutron depolarization in the RF spin flipper and
in the zero in the spectrometer field

Neutron depolarization in the RF spin flipper and in the zero in the spectrometer field



$$Pol = 1 - \frac{2p}{3} \exp\left\{-\frac{pI}{2}\right\} + \frac{4p^2}{3} + \dots$$

$$I = \frac{gB_{\lambda}^2}{GV} = \frac{w_L}{\frac{dJ_B}{dt}}$$

For 10^{-5} depolarization we want $I > 6$. The minimum field in the solenoid guide field, spectrometer + solenoid, along the neutron direction must be .05 Tesla for $G = 24$ Tesla/meter. $I = 6$ is easy to get for the RFSF